

ON Semiconductor®

FDS6675

Single P-Channel, Logic Level, PowerTrench™ MOSFET

General Description

This P-Channel Logic Level MOSFET is produced using ON Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

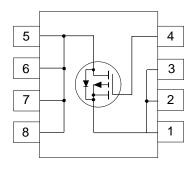
These devices are well suited for notebook computer applications: load switching and power management, battery charging circuits, and DC/DC conversion.

Features

- -11 A, -30 V. $R_{DS(ON)}$ = 0.014 Ω @ V_{GS} = -10 V, $R_{DS(ON)}$ = 0.020 Ω @ V_{GS} = -4.5 V.
- Low gate charge (30nC typical).
- \blacksquare High performance trench technology for extremely low $R_{\text{DS(ON)}}.$
- High power and current handling capability.







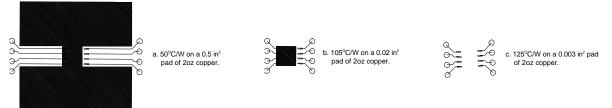
Absolute Maximum Ratings

 $T_A = 25^{\circ}C$ unless otherwise noted

| Symbol | Parameter | | FDS6675 | Units |
|----------------------------|---|--|------------|----------|
| V _{DSS} | Drain-Source Voltage | | -30 | V |
| V _{GSS} | Gate-Source Voltage | | ±20 | V |
| D | Drain Current - Continuous | (Note 1a) | -11 | А |
| | - Pulsed | | -50 | |
| $P_{\scriptscriptstyle D}$ | Power Dissipation for Single Operation | (Note 1a) | 2.5 | W |
| | | (Note 1b) | 1.2 | |
| | | (Note 1c) | 1 | |
| J,T _{STG} | Operating and Storage Temperature Rang | je | -55 to 150 | .€ |
| THERMA | L CHARACTERISTICS | •••••••••••••••••••••••••••••••••••••• | | <u> </u> |
| R _{eJA} | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 50 | °C/W |
| ₹ _{euc} | Thermal Resistance, Junction-to-Case | (Note 1) | 25 | °C/W |

| Symbol | Parameter | Conditions | | Min | Тур | Max | Units |
|--|--|--|-----------------------|-----|-------|-------|-------|
| OFF CHAF | RACTERISTICS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$ | | -30 | | | V |
| Δ BV _{DSS} / Δ T _J | Breakdown Voltage Temp. Coefficient | $I_D = -250 \mu\text{A}$, Referenced to | o 25 °C | | -22 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = -24 \text{ V}, \ V_{GS} = 0 \text{ V}$ | | | | -1 | μA |
| | | | T _J = 55°C | | | -10 | μA |
| I _{GSSF} | Gate - Body Leakage, Forward | $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | | 100 | nA |
| I _{GSSR} | Gate - Body Leakage, Reverse | $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | | -100 | nA |
| ON CHARA | ACTERISTICS (Note 2) | <u>.</u> | | | • | • | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ | | -1 | -1.7 | -3 | V |
| $\Delta V_{GS(th)}/\Delta T_{J}$ | Gate Threshold Voltage Temp. Coefficient | $I_D = 250 \mu\text{A}$, Referenced to | 25 °C | | 4.3 | | mV/°C |
| R _{DS(ON)} | Static Drain-Source On-Resistance | $V_{GS} = -10 \text{ V}, I_{D} = -11 \text{ A}$ | | | 0.011 | 0.014 | Ω |
| | | | T _J =125°C | | 0.016 | 0.023 | |
| | | $V_{GS} = -4.5 \text{ V}, I_{D} = -9 \text{ A}$ | | | 0.015 | 0.02 | |
| I _{D(ON)} | On-State Drain Current | $V_{GS} = -10 \text{ V}, \ V_{DS} = -5 \text{ V}$ | | -50 | | | Α |
| g _{FS} | Forward Transconductance | $V_{DS} = -10 \text{ V}, I_{D} = -11 \text{ A}$ | | | 32 | | S |
| DYNAMIC | CHARACTERISTICS | | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = -15 \text{ V}, \ V_{GS} = 0 \text{ V},$ | | | 3000 | | pF |
| C _{oss} | Output Capacitance | f = 1.0 MHz | | | 870 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 360 | | pF | |
| SWITCHIN | G CHARACTERISTICS (Note 2) | | | | | | |
| t _{D(on)} | Turn - On Delay Time | $V_{DS} = -15 \text{ V}, I_{D} = -1 \text{ A}$ | | | 12 | 22 | ns |
| t, | Turn - On Rise Time | $V_{GEN} = -10 \text{ V}, R_{GEN} = 6 \Omega$ | | | 16 | 27 | ns |
| t _{D(off)} | Turn - Off Delay Time | | | | 50 | 80 | ns |
| t, | Turn - Off Fall Time | | | | 100 | 140 | ns |
| Q_g | Total Gate Charge | $V_{DS} = -15 \text{ V}, I_{D} = -11 \text{ A},$ | | | 30 | 42 | nC |
| Q_{gs} | Gate-Source Charge | V _{GS} = -5 V | | | 9 | | nC |
| Q_{gd} | Gate-Drain Charge | | | | 11 | | nC |
| DRAIN-SO | URCE DIODE CHARACTERISTICS AND MA | XIMUM RATINGS | | | | | |
| I _s | Maximum Continuous Drain-Source Diode Fo | orward Current | | | | -2.1 | Α |
| V _{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_{S} = -2.1 \text{ A}$ (Note | 2) | | -0.72 | -1.2 | V |

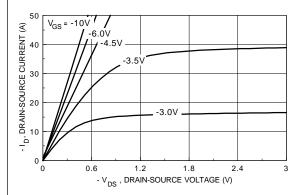
^{1.} $R_{g,u}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{g,c}$ is guaranteed by design while R_{gCA} is determined by the user's board design.



Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2.0%.

Typical Electrical Characteristics



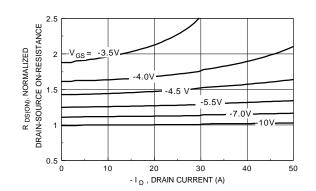
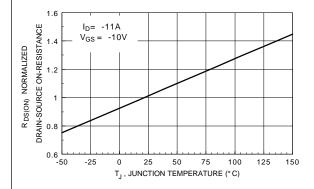


Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Dain Current and Gate Voltage.



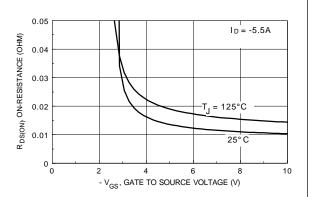
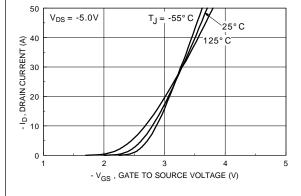


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



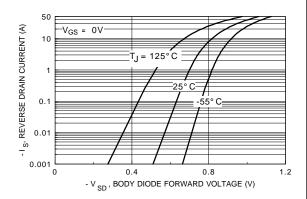
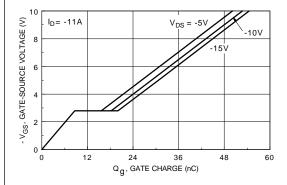


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage
Variation with Source Current
and Temperature.

Typical Electrical Characteristics (continued)



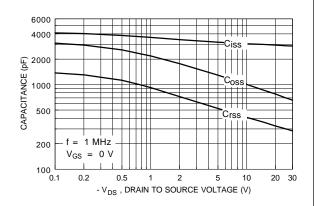
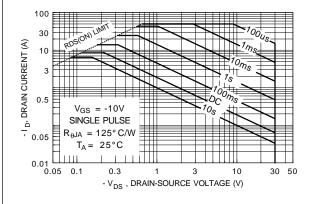


Figure 7. Gate Charge Characteristics.





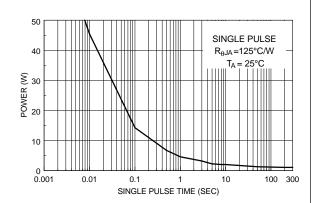


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

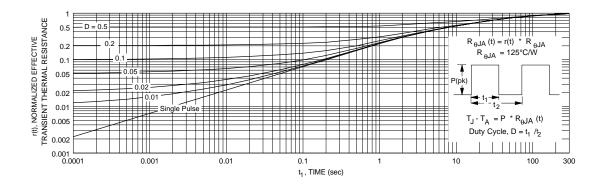
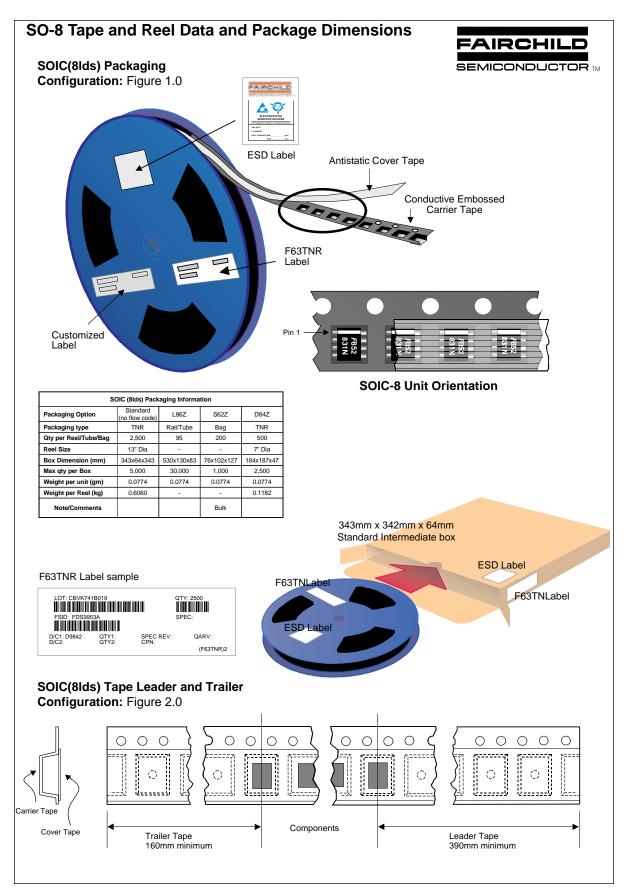


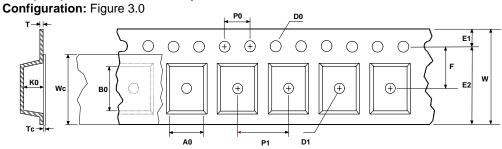
Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.



SO-8 Tape and Reel Data and Package Dimensions, continued

SOIC(8lds) Embossed Carrier Tape



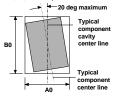


| Dimensions are in millimeter | | | | | | | | | | | | | | |
|------------------------------|-----------------|-----------------|----------------|-----------------|-----------------|-----------------|--------------|-----------------|---------------|---------------|----------------|-----------------------|---------------|-----------------|
| Pkg type | Α0 | В0 | w | D0 | D1 | E1 | E2 | F | P1 | P0 | K0 | т | Wc | Тс |
| SOIC(8lds) (12mm) | 6.50 +/-0.10 | 5.30 +/-0.10 | 12.0 +/-0.3 | 1.55 +/-0.05 | 1.60 +/-0.10 | 1.75 +/-0.10 | 10.25 min | 5.50 +/-0.05 | 8.0 +/-0.1 | 4.0 +/-0.1 | 2.1 +/-0.10 | 0.450 +/- 0.150 | 9.2 +/-0.3 | 0.06 +/-0.02 |

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)
Component Rotation



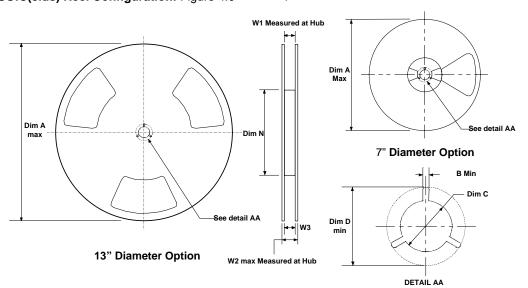
Sketch B (Top View)
Component Rotation



Sketch C (Top View)

Component lateral movement

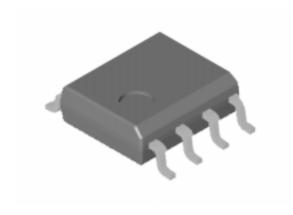
SOIC(8lds) Reel Configuration: Figure 4.0

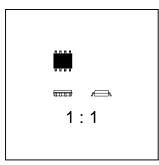


| Dimensions are in inches and millimeters | | | | | | | | | | |
|--|----------------|---------------|--------------|-----------------------------------|---------------|--------------|----------------------------------|---------------|------------------------------|--|
| Tape Size | Reel Option | Dim A | Dim B | Dim C | Dim D | Dim N | Dim W1 | Dim W2 | Dim W3 (LSL-USL) | |
| 12mm | 7" Dia | 7.00 177.8 | 0.059 1.5 | 512 +0.020/-0.008 13 +0.5/-0.2 | 0.795 20.2 | 5.906 150 | 0.488 +0.078/-0.000 12.4 +2/0 | 0.724 18.4 | 0.469 - 0.606 11.9 - 15.4 | |
| 12mm | 13" Dia | 13.00 330 | 0.059 1.5 | 512 +0.020/-0.008 13 +0.5/-0.2 | 0.795 20.2 | 7.00 178 | 0.488 +0.078/-0.000 12.4 +2/0 | 0.724 18.4 | 0.469 - 0.606 11.9 - 15.4 | |

SO-8 Tape and Reel Data and Package Dimensions, continued

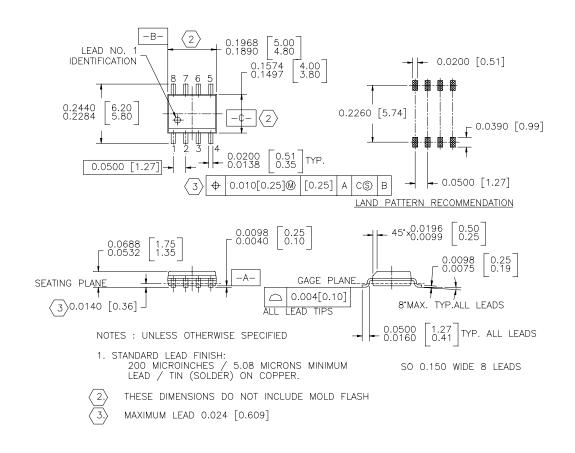
SOIC-8 (FS PKG Code S1)





Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

Part Weight per unit (gram): 0.0774



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